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| Substitute Form PTO-1449<br>(Modified)  | Department of Commerce<br>Patent and Trademark Office | Attorney's Docket No.<br>14603-010US1 | Application No.<br><b>107521322</b> |
| <b>Information Disclosure Statement<br/>by Applicant</b><br>(Use several sheets if necessary) |   | Applicant<br>Brandl et al.            |                                     |
|   |   | Filing Date 1-14-05                   | Group Art Unit 2812                 |
| (37 CFR §1.98(b))   |   |                                       |                                     |

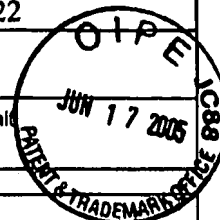
| U.S. Patent Documents |           |                 |                  |                        |       |          |                            |
|-----------------------|-----------|-----------------|------------------|------------------------|-------|----------|----------------------------|
| Examiner Initial      | Desig. ID | Document Number | Publication Date | Patentee               | Class | Subclass | Filing Date If Appropriate |
| /SG/                  | AA        | 6,555,901       | 04/29/03         | Shinji Yoshihara et al | —     | —        |                            |
| /SG/                  | AB        | 5,668,033       | 09/16/97         | Fumio Ohara et al      | —     | —        |                            |
| /SG/                  | AC        | 6,407,381       | 06/18/02         | Thomas Glenn et al     | —     | —        |                            |
| /SG/                  | AD        | 5,895,233       | 04/20/99         | Robert Higashi et al   | —     | —        |                            |
| /                     | AE        |                 |                  |                        |       |          |                            |
|                       | AF        |                 |                  |                        |       |          |                            |
|                       | AG        |                 |                  |                        |       |          |                            |
|                       | AH        |                 |                  |                        |       |          |                            |
|                       | AI        |                 |                  |                        |       |          |                            |
|                       | AJ        |                 |                  |                        |       |          |                            |
|                       | AK        |                 |                  |                        |       |          |                            |

| Foreign Patent Documents or Published Foreign Patent Applications |           |                 |                  |                          |       |          |             |    |
|---|-----------|-----------------|------------------|--------------------------|-------|----------|-------------|----|
| Examiner Initial  | Desig. ID | Document Number | Publication Date | Country or Patent Office | Class | Subclass | Translation |    |
|   |           |                 |                  |                          |       |          | Yes         | No |
| /SG/  | AL        | WO01/46664      | 06/28/01         | WIPO                     | —     | —        |             |    |
| /SG/  | AM        | WO98/05935      | 02/18/98         | WIPO                     | —     | —        |             |    |
| /SG/  | AN        | 2000195827      | 07/14/00         | Abstracts of Japan       | —     | —        |             |    |
| /SG/  | AO        | 09223678        | 08/26/97         | Abstracts of Japan       | —     | —        |             |    |
| /SG/  | AP        | 10-112548       | 04/28/98         | Abstracts of Japan       | —     | —        | Abstract    |    |

| Other Documents (include Author, Title, Date, and Place of Publication) |           |          |
|---|-----------|----------|
| Examiner Initial  | Desig. ID | Document |
| /   | AQ        |          |
|   | AR        |          |
|   | AS        |          |
|   | AT        |          |

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| Examiner Signature<br>/Scott Geyer/  | Date Considered<br>06/12/2007 |
| EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. |                               |

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| Substitute Form PTO-1449<br>(Modified)   | U.S. Department of Commerce<br>Patent and Trademark Office | Attorney's Docket No.<br><b>14603-010US1</b> | Application No.<br><b>10/521,322</b> |
| <b>Information Disclosure Statement<br/>by Applicant</b><br>(Use several sheets if necessary)<br>(37 CFR §1.98(b)) |  | Applicant<br><b>Brandl et al.</b>            |                                      |
|  |  | Filing Date<br><b>January 14, 2005</b>       | Group Art Unit<br><b>2812</b>        |



| U.S. Patent Documents |           |                 |                  |          |       |          |                            |
|-----------------------|-----------|-----------------|------------------|----------|-------|----------|----------------------------|
| Examiner Initial      | Desig. ID | Document Number | Publication Date | Patentee | Class | Subclass | Filing Date If Appropriate |
| <del>/</del>          | AA        |                 |                  |          |       |          |                            |
| <del>/</del>          | AB        |                 |                  |          |       |          |                            |
| <del>/</del>          | AC        |                 |                  |          |       |          |                            |
| <del>/</del>          | AD        |                 |                  |          |       |          |                            |
| <del>/</del>          | AE        |                 |                  |          |       |          |                            |
| <del>/</del>          | AF        |                 |                  |          |       |          |                            |
| <del>/</del>          | AG        |                 |                  |          |       |          |                            |
| <del>/</del>          | AH        |                 |                  |          |       |          |                            |
| <del>/</del>          | AI        |                 |                  |          |       |          |                            |
| <del>/</del>          | AJ        |                 |                  |          |       |          |                            |
| <del>/</del>          | AK        |                 |                  |          |       |          |                            |

| Foreign Patent Documents or Published Foreign Patent Applications |           |                 |                  |                          |       |          |             |    |
|---|-----------|-----------------|------------------|--------------------------|-------|----------|-------------|----|
| Examiner Initial  | Desig. ID | Document Number | Publication Date | Country or Patent Office | Class | Subclass | Translation |    |
|   |           |                 |                  |                          |       |          | Yes         | No |
| <div></div>   | AL        |                 |                  |                          |       |          |             |    |
|   | AM        |                 |                  |                          |       |          |             |    |
|   | AN        |                 |                  |                          |       |          |             |    |
|   | AO        |                 |                  |                          |       |          |             |    |
|   | AP        |                 |                  |                          |       |          |             |    |

| Other Documents (include Author, Title, Date, and Place of Publication) |           |  |
|---|-----------|--|
| Examiner Initial  | Desig. ID | Document   |
| /SG/  | AQ        | English Translation of International Preliminary Examination Report for application PCT/EP2003/005859. |
| <del>/</del>  | AR        |  |
| <del>/</del>  | AS        |  |
| <del>/</del>  | AT        |  |

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| Examiner Signature<br><b>/Scott Geyer/</b>   | Date Considered<br><b>06/12/2007</b> |
| EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. |                                      |